




<p><b>Searched</b></p> 	<p>Application/Control No.</p> <p>10671849</p>	<p>Applicant(s)/Patent Under Reexamination</p> <p>JIAO ET AL.</p>
	<p>Examiner</p> <p>Caschera, Antonio A</p>	<p>Art Unit</p> <p>2628</p>

Class	SubClass	Date	Examiner
345	597, 612, 614, 615, 617	09/01/2006	AC
382	193	09/01/2006	AC

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<b>Search Notes</b>  	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10671849	JIAO ET AL.
	Examiner Caschera, Antonio A	Art Unit 2628

Notes	Date	Examiner
EAST (USPGPUB, USPAT, USOCR, EPO, JPO, Derwent) see attached search history. **345/428, 441, 443, 581, 596, 606, 611 (updated keyword search) **345/597, 612, 614, 615, 617 (updated subclass search) **382/193 (updated subclass search) **382/194, 199, 202, 206, 258, 264, 266, 269, 272 (updated keyword search)	09/01/2006	AC
Searched NPL (IEEE & ACM Digital Libraries)	09/01/2006	AC
Searched Euro & Japanese Patent Website Databases	09/01/2006	AC
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<b><i>Interference Searched</i></b>  	Application/Control No.  10671849	Applicant(s)/Patent Under Reexamination  JIAO ET AL.
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See Attached Search History		09/01/2006	AC

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